Search Notes

Application/Control No.	· Applicant(s)/Patent under Reexamination	
10/717,739	ZHANG, BIN	
Examiner	Art Unit	
Duy M. Dang	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
382	162-167	5/25/07 9/11/07 9/25/07	DD		
348	256				
	240.2				
					
		-			
	,,,,				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		`			
		····			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (pgpub, uspto, derwent, jpo, epo), see printouts	5/25/07 9/11/07 9/25/07	DD		
Inventor search (IEEE and East), see printouts				
IEEE search, see printouts	\			
·				